

**Search Notes**

Application/Control No.

10/001,756

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

BECK ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	270.1	8/2005	[Signature]
548	440		
549	43		
549	48		
438	99		
257	40		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH UPDATED	8/2005	[Signature]

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner